1. Product profile

1.1 General description

The device is designed to protect high-speed interfaces such as SuperSpeed and Hi-Speed USB combination, SD-memory card 3.0 and thunderbolt interfaces against ElectroStatic Discharge (ESD).

The device includes six high-level ESD protection diode structures for ultra high-speed signal lines. The device is encapsulated in a leadless ultra small DFN2111-7 (SOT1358-1) Surface-Mounted Device (SMD) plastic package.

All signal lines are protected by a special diode structure offering ultra low line capacitance of only 0.35 pF. These diodes utilize a snap-back structure in order to provide protection to downstream components from ESD voltages up to ± 15 kV contact exceeding IEC 61000-4-2, level 4.

1.2 Features and benefits

- System-level ESD protection for USB 2.0 and USB 3.1 combination, SD-memory card and thunderbolt interfaces
- Supports SuperSpeed USB 3.1 at 10 Gbps
- All signal lines with integrated rail-to-rail clamping diodes for downstream ESD protection of ±15 kV exceeding IEC 61000-4-2, level 4
- Matched 0.5 mm trace spacing
- Line capacitance of only 0.35 pF for each channel
- Design-friendly 'pass-through' signal routing

1.3 Applications

The device is designed for high-speed receiver and transmitter port protection:

- Portable and wearable devices
- Smartphones and tablet PCs
- TVs and monitors
- DVD recorders and players
- Notebooks, main board graphic cards and ports
- Set-top boxes and game consoles



ESD protection for ultra high-speed interfaces

2. Pinning information

Table 1. Pinning

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	CH1	channel 1 ESD protection		4 0 4 5 0 7
2	GND	ground		
3	CH2	channel 2 ESD protection	7	本本本本本
4	CH3	channel 3 ESD protection	2	2
5	CH4	channel 4 ESD protection	6	←
6	CH5	channel 5 ESD protection	3	
7	CH6	channel 6 ESD protection	Transparent top view	* = **
				aaa-016877

3. Ordering information

Table 2. Ordering information

Type number	Package					
	Name	Description	Version			
PUSB3FR6	DFN2111-7	plastic extremely thin small outline package; no leads; 7 terminals; body $1.1 \times 2.1 \times 0.5$ mm	SOT1358-1			

4. Marking

Table 3. Marking codes

Type number	Marking code
PUSB3FR6	FR

5. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
VI	input voltage		-0.5	+3.3	V
V _{ESD}	electrostatic discharge voltage	IEC 61000-4-2, level 4 [1]			
		contact discharge	-15	+15	kV
		air discharge	-15	+15	kV
I _{PPM}	rated peak pulse current	$t_p = 8/20 \ \mu s$	-7	7	А
T _{amb}	ambient temperature		-40	+85	°C
T _{stg}	storage temperature		-55	+125	°C

[1] All pins to ground.

PUSB3FR6

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6. Characteristics

Table 5. Characteristics

 $T_{amb} = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{BR}	breakdown voltage	I _I = 1 mA		6	-	-	V
I _{LR}	reverse leakage current	per channel; V _I = 3 V		-	1	100	nA
V_{F}	forward voltage	I _I = 1 mA		-	0.7	-	V
C _{line}	line capacitance	f = 1 MHz; V _I = 1.5 V	[1]	-	0.35	0.40	pF
r _{dyn}	dynamic resistance	TLP	[3]				
		positive transient		-	0.29	-	Ω
		negative transient		-	0.29	-	Ω
V_{sbck}	snapback voltage	I _I = 1 A; TLP 100/10 ns		-	1.6	-	V
V_{CL}	clamping voltage	I _{PP} = 5 A; positive transient	[2]	-	3	-	V
		I _{PP} = -5 A; negative transient	[2]	-	-3	-	V

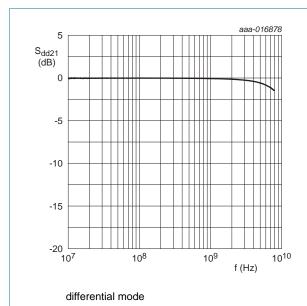
^[1] This parameter is guaranteed by design.

^[2] According to IEC 61000-4-5 (8/20 μ s current waveform).

^{[3] 100} ns Transmission Line Pulse (TLP); 50 Ω ; pulser at 80 ns.

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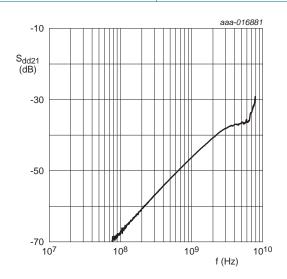


aaa-016880 1.2 а 0.8 0.4 0.0 $V_{I}(V)$

$$a = \frac{C_{line}}{C_{line(V_I = 0 \text{ V})}}$$

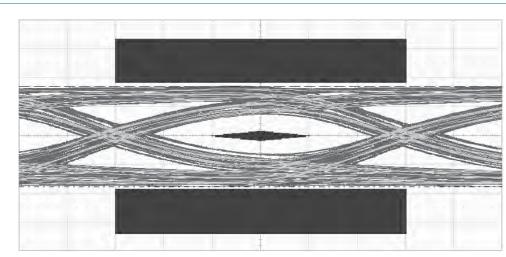
Fig 1. Insertion loss; typical values

Fig 2. Relative capacitance as a function of input voltage; typical values



normalized to 100 Ω Fig 3. Crosstalk; typical values

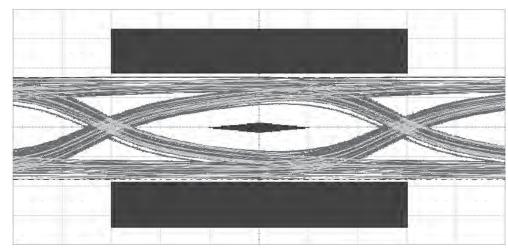
ESD protection for ultra high-speed interfaces



aaa-016882

Data rate: 10 Gbit/s Vertical scale: 325 mV/div Horizontal scale: 16.7 ps/div

Fig 4. USB 3.1 eye diagram, Printed-Circuit Board (PCB) with PUSB3FR6

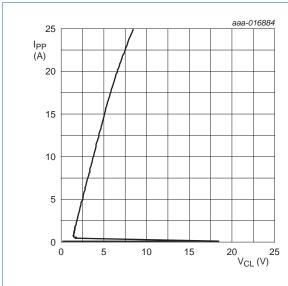


aaa-016883

Data rate: 10 Gbit/s Vertical scale: 325 mV/div Horizontal scale: 16.7 ps/div

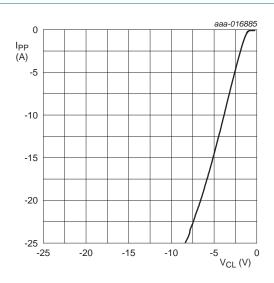
Fig 5. USB 3.1 eye diagram, PCB without PUSB3FR6 (reference)

ESD protection for ultra high-speed interfaces



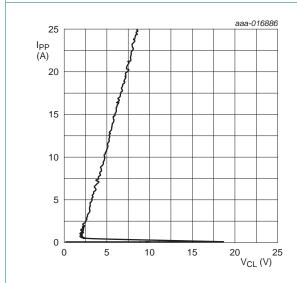
 t_p = 100 ns; Transmission Line Pulse (TLP)

Fig 6. Dynamic resistance with positive clamping; typical values



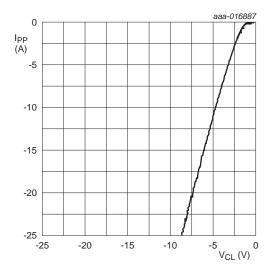
 t_p = 100 ns; Transmission Line Pulse (TLP)

Fig 7. Dynamic resistance with negative clamping; typical values



t_p = 5 ns; Very-Fast TLP (VF-TLP)

Fig 8. Dynamic resistance with positive clamping; typical values

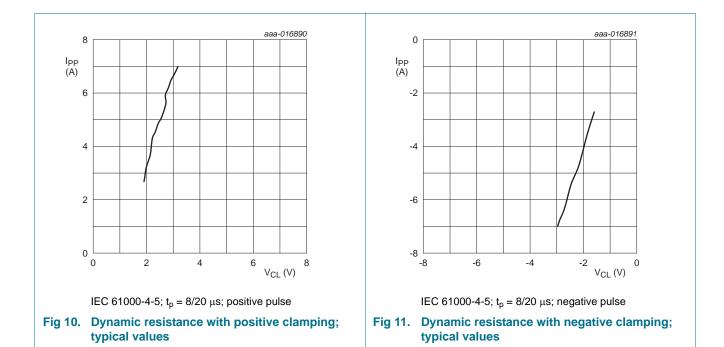


t_p = 5 ns; Very-Fast TLP (VF-TLP)

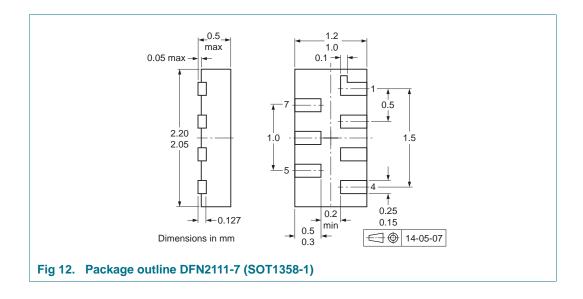
Fig 9. Dynamic resistance with negative clamping; typical values

The device uses an advanced clamping structure showing a negative dynamic resistance. This snapback behavior strongly reduces the clamping voltage to the system behind the ESD protection during an ESD event. Do not connect unlimited DC current sources to the data lines to avoid keeping the ESD protection device in snap-back state after exceeding breakdown voltage (due to an ESD pulse for instance).

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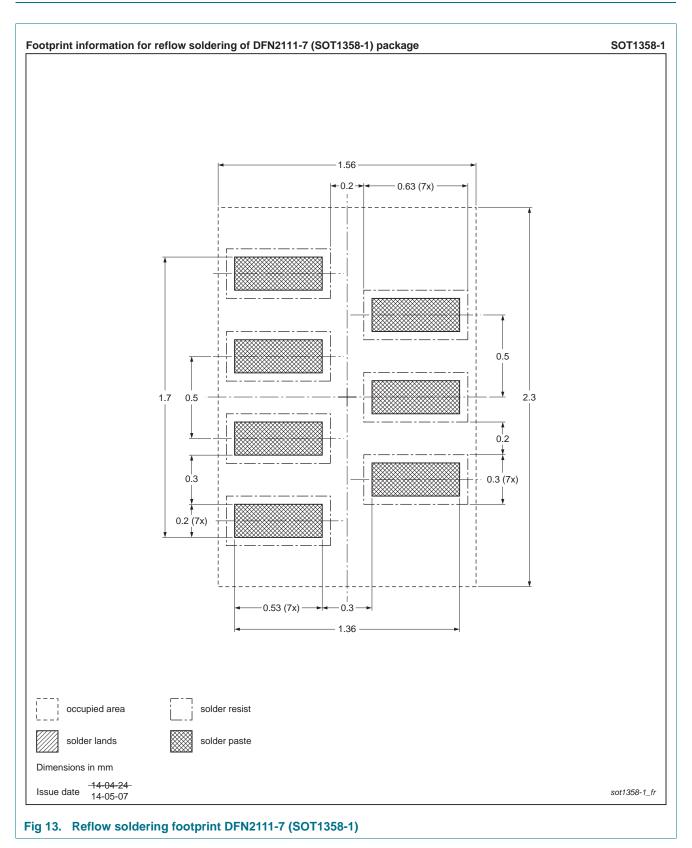


7. Package outline



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8. Soldering



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9. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PUSB3FR6 v.1	20150225	Product data sheet	-	-

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10. Legal information

10.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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